# **MAXIMUM RATINGS**

Symbol	Parameter	Parameter			
V <sub>CC</sub>	DC Supply Voltage	-0.5 to +7.0	V		
V <sub>IN</sub>	DC Input Voltage	-0.5 to +7.0	V		
V <sub>OUT</sub>	DC Output Voltage		-0.5 to +7.0	V	
I <sub>IK</sub>	DC Input Diode Current	V <sub>IN</sub> < GND	-20	mA	
lok	DC Output Diode Current	V <sub>OUT</sub> < GND	±20	mA	
Ιο	DC Output Source/Sink Current	±12.5	mA		
I <sub>CC</sub>	DC Supply Current Per Supply Pin	±25	mA		
I <sub>GND</sub>	DC Ground Current per Ground Pin	±25	mA		
T <sub>STG</sub>	Storage Temperature Range	−65 to +150	°C		
T <sub>L</sub>	Lead Temperature, 1 mm from Case for 10 Second	260	°C		
$T_J$	Junction Temperature Under Bias	150	°C		
MSL	Moisture Sensitivity	Level 1			
F <sub>R</sub>	Flammability Rating Oxygen	UL 94 V-0 @ 0.125 in			
I <sub>LATCHUP</sub>	Latchup Performance Above V <sub>CC</sub> and Below GND	±500	mA		

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

# RECOMMENDED OPERATING CONDITIONS

Symbol	Parameter	Min	Max	Unit
V <sub>CC</sub>	Positive DC Supply Voltage	1.65	5.5	V
V <sub>IN</sub>	Digital Input Voltage	0	5.5	V
V <sub>OUT</sub>	Output Voltage	0	5.5	٧
T <sub>A</sub>	Operating Free-Air Temperature	-55	+125	°C
Δt/ΔV	Input Transition Rise or Fall Rate $ \begin{array}{c} V_{CC} = 3.3 \ V \pm 0.3 \ V \\ V_{CC} = 5.0 \ V \pm 0.5 \ V \end{array} $	0 0	100 20	ns/V

Measured with minimum pad spacing on an FR4 board, using 10 mm-by-1 inch, 2 ounce copper trace no air flow.
 Tested to EIA / JESD78.

# DC ELECTRICAL CHARACTERISTICS

			Voc	V <sub>CC</sub>		С	T <sub>A</sub> = +85°C		T <sub>A</sub> = -55°C to +125°C		
Symbol	Parameter	Conditions	(V)	Min	Тур	Max	Min	Max	Min	Max	Unit
V <sub>IH</sub>	Low-Level Input Voltage		1.65	0.75 x V <sub>CC</sub>			0.75 x V <sub>CC</sub>				V
			2.3 to 5.5	0.70 x V <sub>CC</sub>			0.70 x V <sub>CC</sub>				
V <sub>IL</sub>	Low-Level Input Voltage		1.65			0.25 x V <sub>CC</sub>		0.25 x V <sub>CC</sub>		0.25 x V <sub>CC</sub>	V
			2.3 to 5.5			0.30 x V <sub>CC</sub>		0.30 x V <sub>CC</sub>		0.30 x V <sub>CC</sub>	
V <sub>OL</sub>	Low-Level Output Voltage	$V_{IN} = V_{IH}$ or $V_{IL}$ $I_{OL} = 50 \mu A$	2.0 3.0 4.5		0 0 0	0.1 0.1 0.1		0.1 0.1 0.1		0.1 0.1 0.1	V
		$V_{IN} = V_{IH}$ or $V_{IL}$ $I_{OL} = 4$ mA $I_{OL} = 8$ mA	3.0 4.5			0.36 0.36		0.44 0.44		0.52 0.52	
I <sub>LKG</sub>	Z-State Output Leakage Current	$V_{IN} = V_{IH},$ $V_{OUT} = V_{CC}$ or $GND$	5.5			±0.25		±2.5		±5.0	μΑ
I <sub>IN</sub>	Input Leakage Current	$0 \le V_{IN} \le 5.5 V$	0 to 5.5			±0.1		±1.0		±1.0	μΑ
I <sub>OFF</sub>	Power Off Input Leakage Current	$0 \le V_{IN},$ $V_{OUT} \le 5.5 V$	0			0.25		2.5		5.0	μΑ
Icc	Quiescent Supply Current	$0 \le V_{IN} \le V_{CC}$	5.5			1.0		10		40	μΑ

# AC ELECTRICAL CHARACTERISTICS (Input $t_f = t_f = 3.0 \text{ nS}$ )

		V <sub>CC</sub>	Test		T <sub>A</sub> = 25	°C	T <sub>A</sub> =	+85°C	_ ~	-55°C  25°C	
Symbol	Parameter	(S)	Condition	Min	Тур	Max	Min	Max	Min	Max	Unit
t <sub>PZL</sub>	Propagation Delay, Input A to Output Y	3.0 to 3.6	$R_L = R_1 = 50 \Omega$ $C_L = 15 pF$		5.0	7.1		8.5		10	ns
			$R_L = R_1 = 50 \ \Omega$ $C_L = 50 \ pF$		7.5	10.6		12		14.5	
		4.5 to 5.5	$R_L = R_1 = 50 \Omega$ $C_L = 15 \text{ pF}$		3.8	5.5		6.5		8.0	
			$R_L = R_1 = 50 \ \Omega$ $C_L = 50 \ pF$		5.3	7.5		8.5		10	
t <sub>PLZ</sub>	Output Disable Time	3.0 to 3.6	$R_L = R_1 = 50 \Omega$ $C_L = 50 pF$		7.5	10.6		12		14.5	ns
		4.5 to 55	$R_L = R_1 = 50 \Omega$ $C_L = 50 \text{ pF}$		5.3	7.5		8.5		10	
C <sub>IN</sub>	Input Capacitance				4.0	10		10		10	pF
C <sub>PD</sub>	Power Dissipation Capacitance (Note 3)	5.0			18						pF

<sup>3.</sup> C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the dynamic operating current consumption without load. Average operating current can be obtained by the equation  $I_{CC(OPR)} = C_{PD} \bullet V_{CC} \bullet f_{in} + I_{CC}$ . C<sub>PD</sub> is used to determine the no–load dynamic power consumption:  $P_D = C_{PD} \bullet V_{CC}^2 \bullet f_{in} + I_{CC} \bullet V_{CC}$ .

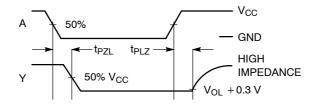
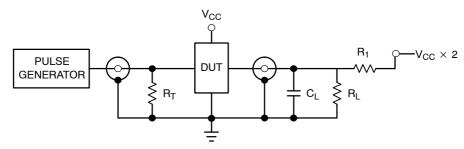


Figure 3. Switching Waveforms



 $R_T = Z_{OUT}$  of pulse generator (typically 50  $\Omega$ )

Figure 4. Test Circuit

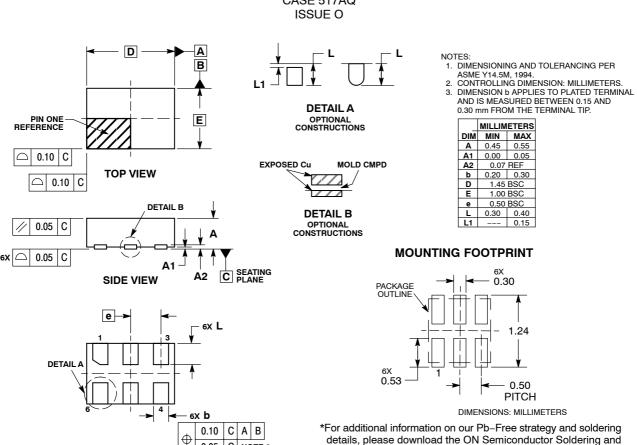
# **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NLU2G07MUTCG	UDFN6, 1.2 x 1.0, 0.4P (Pb-Free)	3000 / Tape & Reel
NLU2G07AMX1TCG	ULLGA6, 1.45 x 1.0, 0.5P (Pb-Free)	3000 / Tape & Reel
NLU2G07BMX1TCG	ULLGA6, 1.2 x 1.0, 0.4P (Pb-Free)	3000 / Tape & Reel
NLU2G07CMX1TCG	ULLGA6, 1.0 x 1.0, 0.35P (Pb-Free)	3000 / Tape & Reel
NLU2G07AMUTCG	UDFN6, 1.45 x 1.0, 0.5P (Pb-Free)	3000 / Tape & Reel
NLU2G07CMUTCG	UDFN6, 1.0 x 1.0, 0.35P (Pb-Free)	3000 / Tape & Reel

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

#### PACKAGE DIMENSIONS

# UDFN6 1.45x1.0, 0.5P CASE 517AQ ISSUE O



Mounting Techniques Reference Manual, SOLDERRM/D.

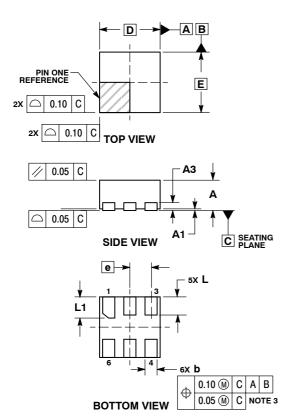
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**BOTTOM VIEW** 

C NOTE 3

# PACKAGE DIMENSIONS

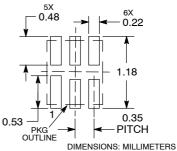
# UDFN6 1.0x1.0, 0.35P CASE 517BX ISSUE O



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETERS.
  3. DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.20 MM FROM TERMINAL TIP.
  4. PACKAGE DIMENSIONS EXCLUSIVE OF BURRS AND MOLD FLASH.

	MILLIMETERS					
DIM	MIN	MAX				
Α	0.45	0.55				
A1	0.00	0.05				
А3	0.13 REF					
b	0.12	0.22				
D	1.00 BSC					
E	1.00	BSC				
е	0.35 BSC					
L	0.25	0.35				
L1	0.30	0.40				

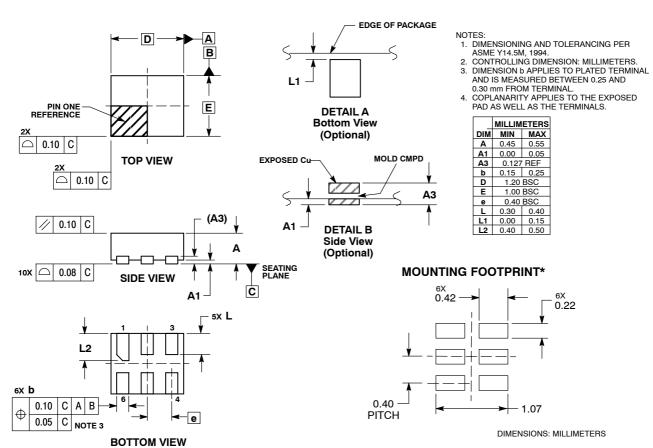
# RECOMMENDED SOLDERING FOOTPRINT\*



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

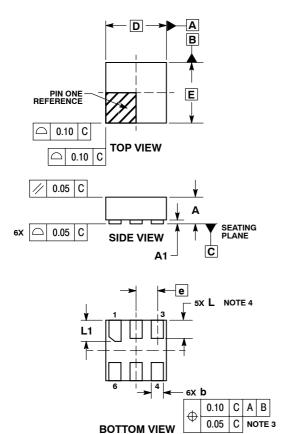
**UDFN6, 1.2x1.0, 0.4P**CASE 517AA
ISSUE D



<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

# **PACKAGE DIMENSIONS**

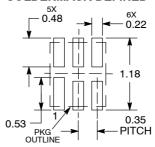
ULLGA6 1.0x1.0, 0.35P CASE 613AD ISSUE A



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETERS.
  3. DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM THE TERMINAL TIP.
  4. A MAXIMUM OF 0.05 PULL BACK OF THE PLATED TERMINAL FROM THE EDGE OF THE PACKAGE IS A LI OWED. PACKAGE IS ALLOWED.

	MILLIMETERS					
DIM	MIN	MAX				
Α	-	0.40				
A1	0.00	0.05				
b	0.12	0.22				
D	1.00 BSC					
E	1.00 BSC					
е	0.35 BSC					
L	0.25	0.35				
11	0.30	0.30 0.40				

# **MOUNTING FOOTPRINT SOLDERMASK DEFINED\***

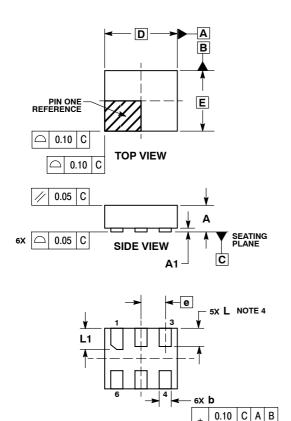


DIMENSIONS: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

# PACKAGE DIMENSIONS

ULLGA6 1.2x1.0, 0.4P CASE 613AE **ISSUE A** 



**BOTTOM VIEW** 

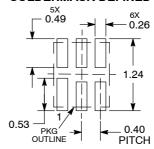
 $\oplus$ 

0.05 C NOTE 3

- NOTES:
  1. DIMENSIONING AND TOLERANCING PER
  ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETERS.
  3. DIMENSION & APPLIES TO PLATED TERMINAL
  AND IS MEASURED BETWEEN 0,15 AND
- 0.30 mm FROM THE TERMINAL TIP. A MAXIMUM OF 0.05 PULL BACK OF THE PLATED TERMINAL FROM THE EDGE OF THE PACKAGE IS ALLOWED.

		<b>MILLIMETERS</b>					
DI	M	MIN	MAX				
-	١		0.40				
Α	1	0.00	0.05				
k	)	0.15	0.25				
	)	1.20 BSC					
E		1.00	BSC				
•	,	0.40 BSC					
L	_	0.25	0.35				
L	1	0.35	0.45				

### **MOUNTING FOOTPRINT SOLDERMASK DEFINED\***

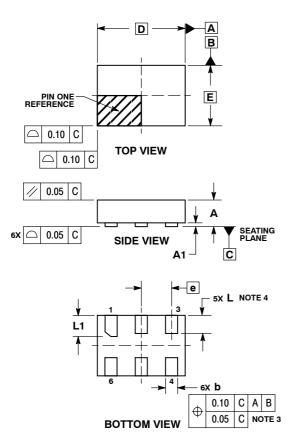


**DIMENSIONS: MILLIMETERS** 

<sup>\*</sup>For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

#### PACKAGE DIMENSIONS

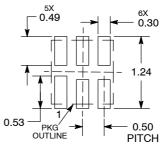
### ULLGA6 1.45x1.0, 0.5P CASE 613AF **ISSUE A**



- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETERS.
- DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM THE TERMINAL TIP.
- A MAXIMUM OF 0.05 PULL BACK OF THE PLATED TERMINAL FROM THE EDGE OF THE PACKAGE IS ALLOWED.

	MILLIMETERS				
DIM	MIN	MAX			
Α		0.40			
A1	0.00	0.05			
b	0.15	0.25			
D	1.45 BSC				
E	1.00 BSC				
е	0.50 BSC				
L	0.25	0.35			
L1	0.30	0.40			

#### **MOUNTING FOOTPRINT** SOLDERMASK DEFINED\*



**DIMENSIONS: MILLIMETERS** 

\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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